Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/680,660	VENKATESH ET AL.	
Examiner	**Art Unit**	
Alan S. Chen	2182	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPAT, USPGPUB, EPO, JPO, DERWEND, IBM_TDB; Inventor's search;	5/1/2007	ASC
limited class search: 710/22-28,33	5/1/2007	ASC